AMC 2024

2024 Advanced Materials Characterization Workshop

June 4 and 5

Materials Research Laboratory — University of Illinois at Urbana-Champaign Registration required — only \$80

http://go.illinois.edu/amc2024

	Tuesday, June 4	
8 am	Registration and coffee / breakfast (MRL 2 nd floor Main Hallv	vay)
8:40	Welcome and introduction to MRL (ESB 190)	Moderator: M. Sardela Streaming: A. Popescu
9	Tutorial 1: Rutherford backscattering analysis Tim Spila, MRL, University of Illinois	
9:30	Tutorial 2: Optical and spectroscopic characterization (I) Julio Soares, MRL, University of Illinois	
10	Coffee Break	
10:30	Tutorial 3: Optical and spectroscopic characterization (II) Julio Soares, MRL, University of Illinois	Moderator: R. Goncalves
11	Tutorial 4: Atomic force microscopy Kathy Walsh, MRL, University of Illinois	Streaming: S. S. Melo
12	Lunch	
1 pm	New horizons for TEM innovation: advancements in technology driving new materials research and discovery Lee Casalena, ThermoFisher	Moderator: G. MacDougall Streaming: L. Westfall
1:20	Instrumentation for magnetic and transport measurements Rick Hapanowicz, Quantum Design	
1:40	Nanoscale chemical characterization of surface functionalization/modification Patrick O'Hara, Molecular Vista	
2	Tutorial 5: Macro scale material characterization for hard and soft materials David Ehrhardt, MRL, University of Illinois	
2:40	Coffee Break	
3:10	Tutorial 6: Nanomechanical characterization Kathy Walsh, MRL, University of Illinois	Moderator: R. Basu Streaming: S. S. Melo
3:40	Improved AFM measurement accuracy and precision using quadrature phase differential interferometry for tip displacement sensing Ted Limpoco, Oxford Instruments	
4 - 5	Tutorial 7: X-ray analysis Mauro Sardela, MRL, University of Illinois	
5:30-6:30	Reception and networking (MRL 2 nd floor Main Hallway)	

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Wednesday, June 5		
8 am	Coffee / Breakfast (MRL 2 nd floor)	
8:30	Tutorial 8: Atom probe tomography Tim Spila, MRL, University of Illinois	Moderator: M. Hota
9	Tutorial 9: Scanning electron microscopy & focused ion beam Jade Wang, MRL, University of Illinois	Streaming: A. Popescu
10	Coffee Break	
10:30	Material characterization using a KRAKEN™ microscope Torben Purz, MONSTR Sense Technologies	Moderator:
10:50	Introduction to dynamic vapor sorption and its uses for advanced characterization of porous materials Chris Vander Tuuk, Surface Measurement Systems	T. Joshi Streaming: X. Wang
11:10	Tutorial 10: Characterization of soft materials and polymers Roddel Remy, MRL, University of Illinois	
12	Lunch	
1 pm	Thermogravimetric analysis (TGA) with evolved gas coupling via FTIR, QMS, GCMS and automatic software evaluation Peter Vichos, Netzch	Moderator: M. Ali
1:20	Tutorial 11: X-ray photoelectron spectroscopy Rick Haasch, MRL, University of Illinois	Streaming: A. Sibert
2:10	Tutorial 12: Transmission electron microscopy (I) Kristen Flatt, MRL, University of Illinois	
2:30	Coffee Break	
3	Tutorial 13: Biomaterials and cryo-EM Kristen Flatt, MRL, University of Illinois	Moderator: J. Lopez
3:35 – 4:15	Tutorial 14: Transmission electron microscopy (II) Honghui Zhou, MRL, University of Illinois	Streaming: R Goncalves
4:30 – 5:30	MRL lab tours (meet at MRL 2 nd floor Main Hallway)	

All presentations are in Room 190 ESB (Engineering Sciences Building Auditorium)

Vendors' exhibit show: June 4, 9 am-6 pm, and June 5, 9 am-3 pm on the MRL 2nd floor main hallway.

<u>Platinum sponsors</u>: Molecular Vista, Monstr Sense Technologies, Netzch, Oxford Instruments, Quantum Design, Surface Measurement Systems, ThermoFisher.

<u>Sponsors</u>: Angstrom, Anton Paar, Bruker, DMS, Gatan EDAX, Hitachi, Horiba, JEOL, Kratos, KJ Lesker, Nanoscribe, Park Systems, PHC Co., Physical Electronics, Samco, Thomas Scientific Leica, Waters TA.

Registration and details, go to

